

Code: 9D06101

M.Tech I Semester Regular & Supplementary Examinations February 2016

DIGITAL SYSTEM DESIGN

(Common to DSCE, DECS, ECE, VLSIES, ESVLSI, VLSIESD & MNE) (For students admitted in 2011, 2012, 2013, 2014 & 2015 only)

Time: 3 hours Max Marks: 60

Answer any FIVE questions All questions carry equal marks

- 1 (a) Discuss the primary constructs that are used in VHDL.
 - (b) Design a 4 X 3 ROM to perform:

$$F_1 = \sum (0, 1, 2, 3, 7)$$

$$F_2 = \sum (1, 2, 3, 5, 7)$$

$$F_3 = \sum (0, 2, 4, 6)$$

- 2 (a) Draw the symbols used in ASM chart and explain.
 - (b) Describe important features of FPGA.
- Construct the test set of output function of the circuit $F(X_1, X_2, X_3) = X_1X_3 + (\overline{X_2 + X_3})$. Using path sensitizing method.
- 4 (a) With a neat circuit diagram, describe the working of a signature analyzer.
 - (b) Write short notes on testing for bridging faults.
- 5 (a) Explain about fault detection and location in sequential circuits.
 - (b) Discuss about synchronizing experiments of fault diagnosis in sequential circuits.
- 6 (a) Explain the various types of cross point fault that occur in PLA's.
 - (b) Explain PLA folding.
- 7 (a) Explain how test generation can be achieved in testing a PLA.
 - (b) Discuss briefly about testable PLA design.
- 8 Explain the fundamental mode model for asynchronous sequential machine design.
